

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/925,700 SAWADA ET AL.	
		Examiner	Art Unit	Page 1 of 1 Edgardo San Martin 2837

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*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-6,677,724	01-2004	Kim et al.	318/700
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

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NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
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X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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